



SUPER-SEMI



Super Junction Insulated Gate Bipolar Transistor

650V Trench and Super Junction IGBT
SI*90N65G2HP2D

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www.supersemi.com.cn

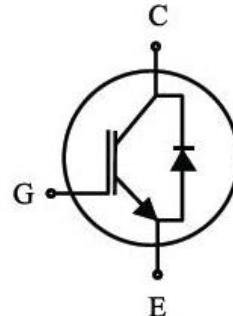
SIW90N65G2HP2D

650V Trench and Super Junction IGBT

General Description

Super-Semi Trench and Super Junction IGBTs, designed according to the super junction (SJ) technology. The SJ-IGBT series provides low switching losses, high energy efficiency and high avalanche ruggedness for motor control, solar application and welding machine, etc.

V_{CE}	650	V
I_C	90	A
V_{CE(sat)}, I_C=90A	1.75	V



Features

- High breakdown voltage to 650V for improved reliability
- Super junction Technology offering :
 - High speed switching
 - High ruggedness, temperature stable
 - Low $V_{CE(sat)}$
 - Easy parallel switching capability due to positive temperature coefficient in $V_{CE(sat)}$
- Enhanced avalanche capability

SIW90N65G2HP2D



Applications

- Uninterruptible Power Supply(UPS)
- Power Factor Correction(PFC)
- Welding Converters
- Inverter
- Converter with high switching frequency

Absolute Maximum Ratings ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit
V_{CE}	Collector-Emitter Breakdown Voltage	650	V
I_C	DC collector current* -Continuous ($T_C = 25^\circ\text{C}$), limited by bondwire -Continuous ($T_C = 100^\circ\text{C}$)	100 90	A
I_F	Diode Forward current* -Continuous ($T_C = 25^\circ\text{C}$), limited by bondwire -Continuous ($T_C = 100^\circ\text{C}$)	100 90	A
V_{GE}	Continuous Gate-Emitter Voltage	± 20	V
	Transient Gate-Emitter Voltage	± 30	V
	Turn off safe operating area $V_{CE} \leq 650\text{V}$, $T_j \leq 150^\circ\text{C}$, $t_p = 1\mu\text{s}$	360	A
I_{CM}	Pulsed Collector Current, $V_{GE} = 15\text{V}$, t_p limited by T_{jmax}	360	A
T_j	Operating junction temperature	-40 to +175	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to +150	$^\circ\text{C}$
P_D	Power Dissipation, $T_C = 25^\circ\text{C}$	400	W
M	Mounting torque (TO-247) M3 and M3.5 screws	60	Ncm
	Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s	260	$^\circ\text{C}$

* Current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	Max. Value	Unit
$R_{\theta JC}$ (IGBT)	IGBT Thermal Resistance, Junction-to-Case	0.38	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$ (FRD)	Diode Thermal Resistance, Junction-to-Case	0.45	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	40	$^\circ\text{C}/\text{W}$

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static Characteristics						
BV_{CES}	Collector-Emitter Breakdown Voltage	$V_{\text{GE}} = 0\text{V}, I_C = 250\mu\text{A}$	650	-	-	V
		$V_{\text{GE}} = 0\text{V}, I_C = 1\text{mA}$	650	-	-	V
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GE}} = V_{\text{CE}}, I_C = 250\mu\text{A}$	4.0	4.7	6.0	V
$V_{\text{CE}(\text{sat})}$	Collector-Emitter Saturation Voltage	$V_{\text{GE}} = 15\text{V}, I_C = 90\text{A}$ $-T_J = 25^\circ\text{C}$ $-T_J = 150^\circ\text{C}$	-	1.75 2.3	2.1	V V
I_{CES}	Zero Gate Voltage Collector Current	$V_{\text{CE}} = 650\text{V}, V_{\text{GE}} = 0\text{V}$ $-T_J = 25^\circ\text{C}$ $-T_J = 150^\circ\text{C}$	-	1 1000	20	μA μA
I_{GES}	Gate-Emitter Leakage Current	$V_{\text{CE}} = 0\text{V}, V_{\text{GE}} = \pm 20\text{V}$	-	-	100	nA
g_{FS}	Forward Transconductance	$V_{\text{CE}} = 20\text{V}, I_C = 100\text{A}$	-	110	-	S

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Dynamic Characteristics						
Cies	Input Capacitance	$V_{\text{CE}} = 25\text{V}, V_{\text{GE}} = 0\text{V}, f = 250\text{KHz}$	-	4210	-	pF
Coes	Output Capacitance		-	264	-	pF
Cres	Reverse Transfer Capacitance		-	82	-	pF
Q_G	Gate Charge	$V_{\text{CC}} = 400\text{V}, I_C = 100\text{A}, V_{\text{GE}} = 15\text{V}$	-	172	-	nC

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Switching Characteristics, Inductive Load, $T_j=25^\circ\text{C}$						
td(on)	Turn-On Delay Time	$V_{cc} = 400\text{V}, I_C = 90\text{A}$ $V_{GE} = 0\text{V}/15\text{V}$ $R_g = 10\Omega$	-	57	-	ns
tr	Turn-On Rise Time		-	61	-	ns
td(off)	Turn-Off Delay Time		-	191	-	ns
tf	Turn-Off Fall Time		-	74	-	ns
Eon	Turn-on Energy		-	1.18	-	mJ
Eoff	Turn-off Energy		-	1.02	-	mJ

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Diode Characteristics and Maximum Ratings, $T_j=25^\circ\text{C}$						
V_{FM}	Diode Forward Voltage	$I_F = 90\text{A}$ $VR = 400\text{V}, I_F = 90\text{A}$ $dI_F/dt = 100\text{A}/\mu\text{s}$	-	1.80	2.2	V
Trr	Reverse Recovery Time		-	47	-	ns
Irr	Reverse Recovery Current		-	49	-	A
Qrr	Reverse Recovery Charge		-	1.04	-	μC

Electrical Characteristics (T_j= 150 °C)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Switching Characteristics, Inductive Load, T_j=150°C						
td(on)	Turn-On Delay Time	V _{CC} = 400V, I _C = 90A V _{GE} = 0V/15V R _G = 10Ω	-	55	-	ns
tr	Turn-On Rise Time		-	62	-	ns
td(off)	Turn-Off Delay Time		-	203	-	ns
tf	Turn-Off Fall Time		-	72	-	ns
Eon	Turn-on Energy		-	1.94	-	mJ
Eoff	Turn-off Energy		-	1.11	-	mJ

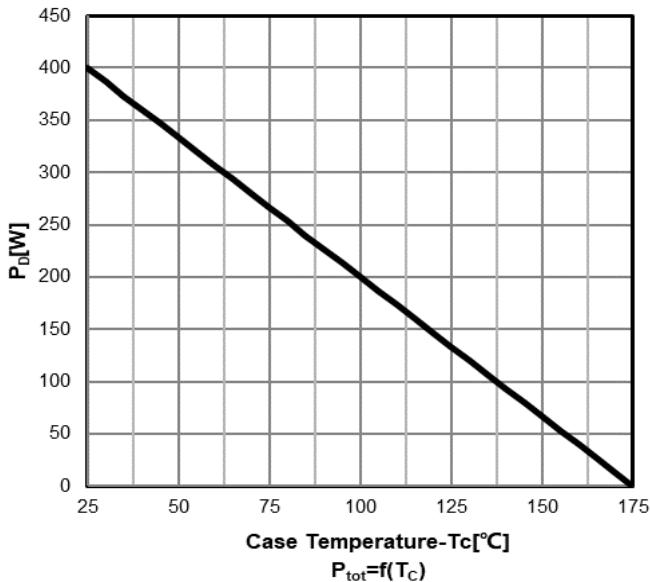
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Diode Characteristics and Maximum Ratings, T_j=150°C						
V _{FM}	Diode Forward Voltage	I _F = 90A VR = 400V, I _F = 90A dI _F /dt = 100A/μs	-	1.6	-	V
Trr	Reverse Recovery Time		-	160	-	ns
Irr	Reverse Recovery Current		-	61	-	A
Qrr	Reverse Recovery Charge		-	4.44	-	μC



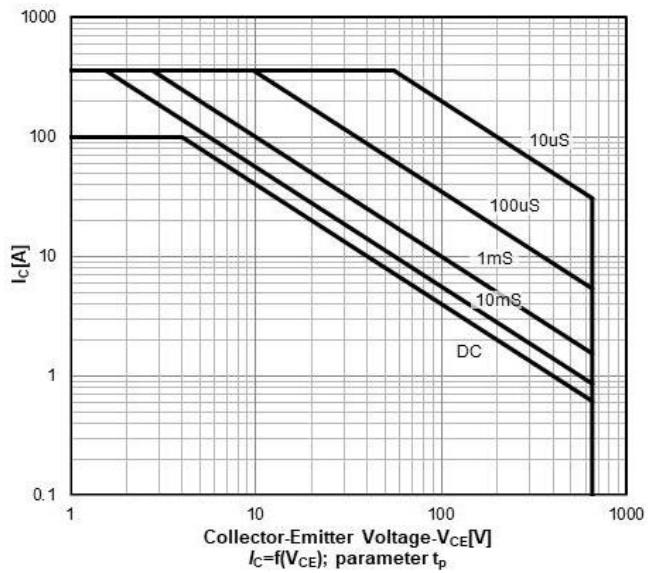
Typical Performance Characteristics

SiW90N65G2HP2D 650V Trench and Super Junction IGBT

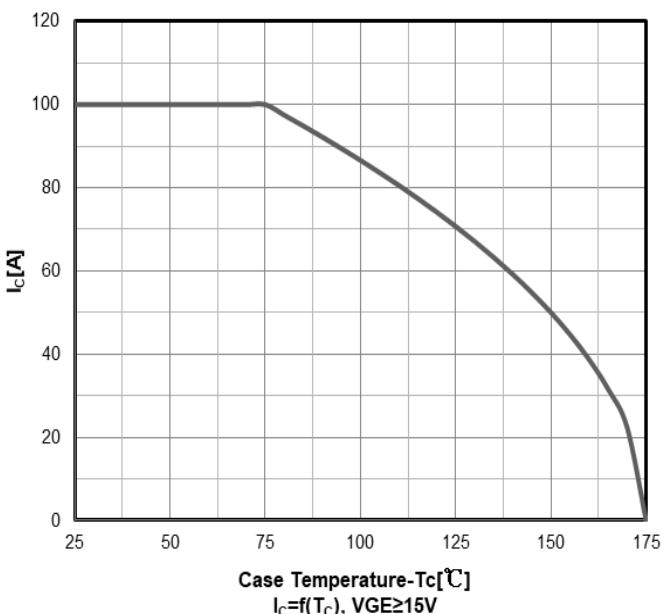
Power dissipation



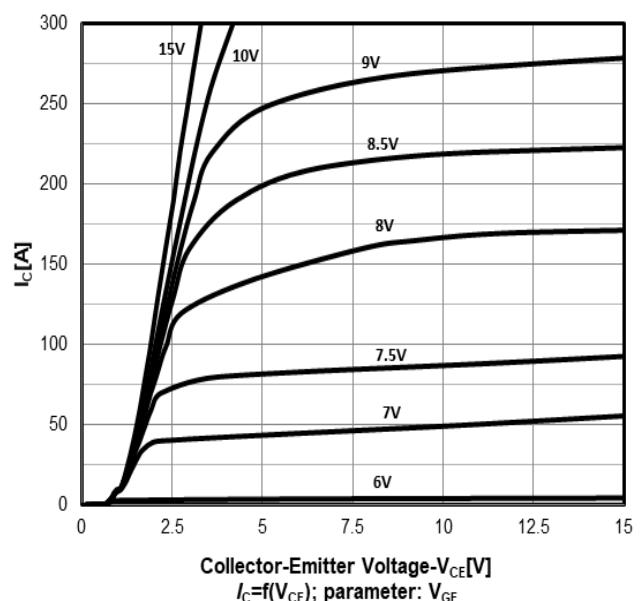
Safe operating area $T_a=25\text{ }^{\circ}\text{C}$



Collector current as a function of Case temperature



Typ. Output characteristics $T_j=25\text{ }^{\circ}\text{C}$

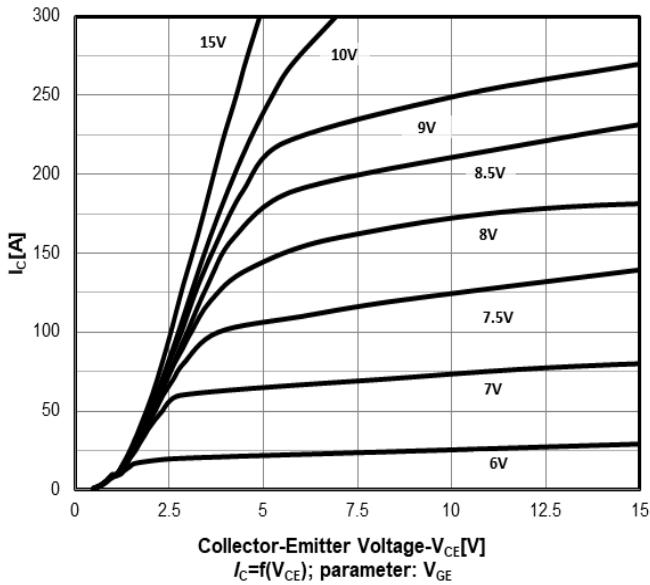




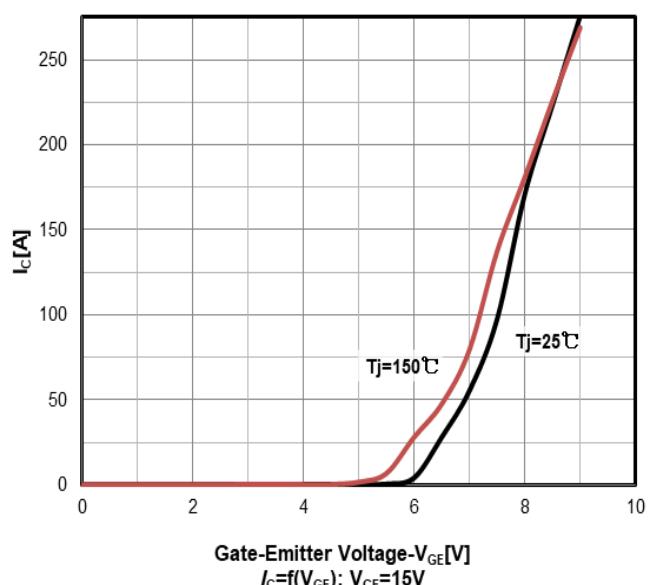
Typical Performance Characteristics

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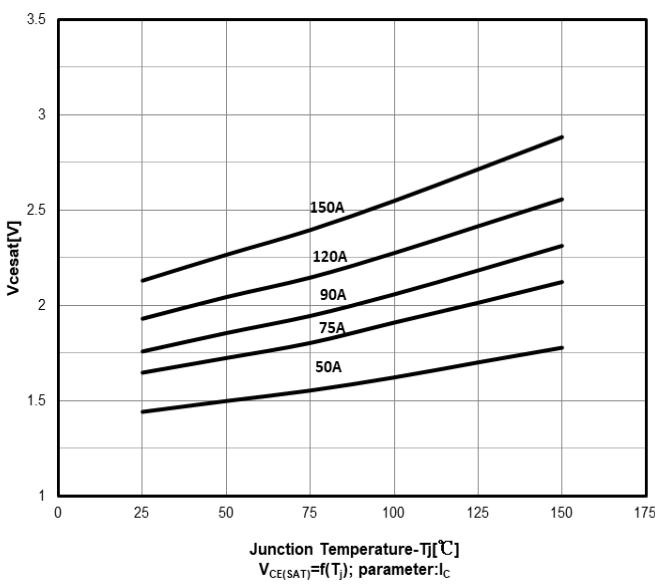
Typ. Output characteristics
 $T_j=150\text{ }^\circ\text{C}$



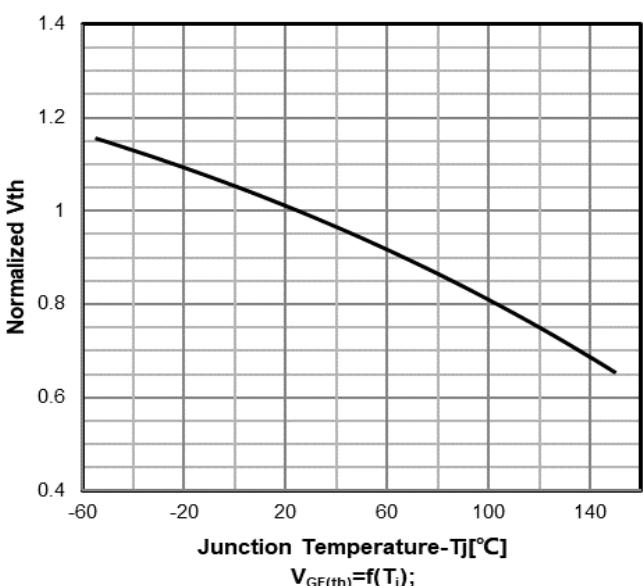
Typ. Transfer characteristics



Typ. Collector-emitter saturation voltage as a function of junction temperature ($V_{GE}=15\text{V}$)



Normalized $V_{GE(\text{th})}$ vs. temperature



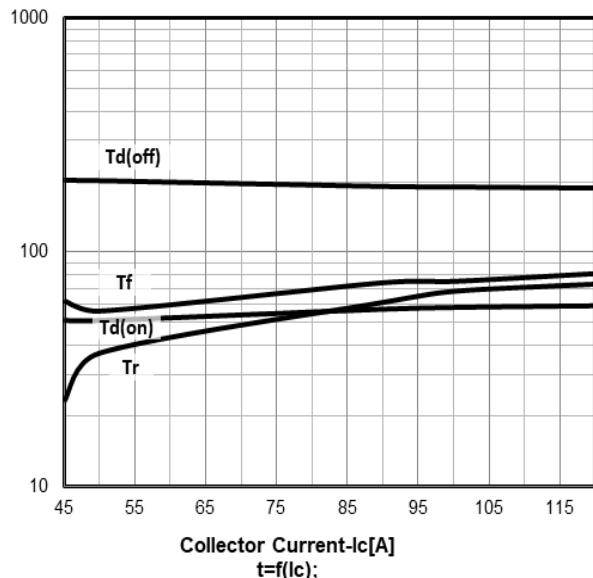


Typical Performance Characteristics

SiW40N65G2HP2G 650V Trench and Super Junction IGBT

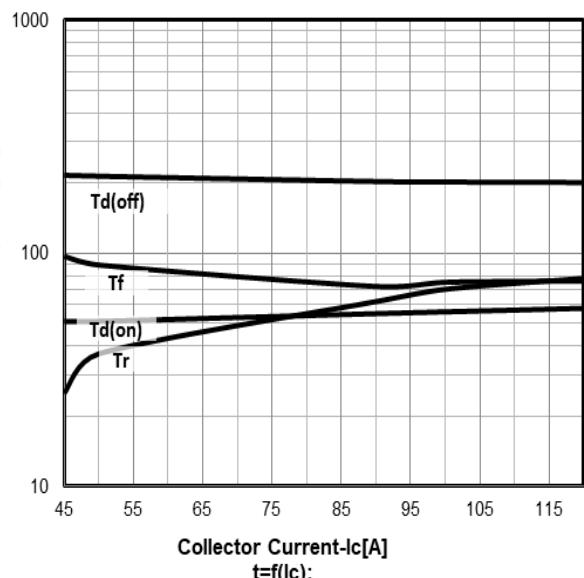
Switching times vs collector current
 $T_j=25\text{ }^\circ\text{C}$

t, switching times

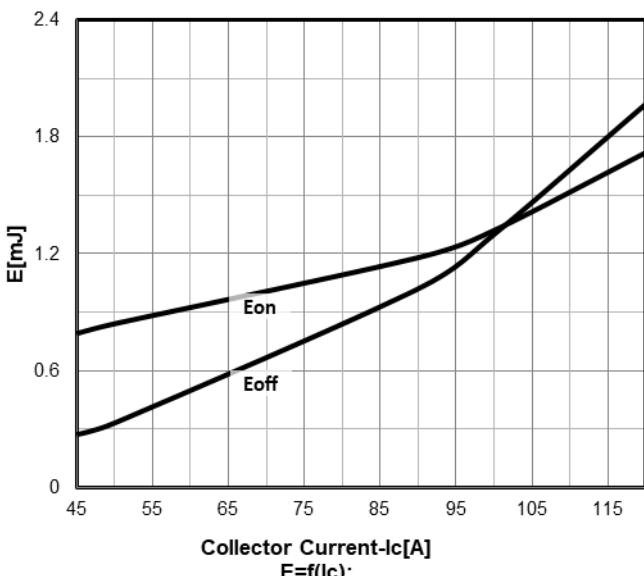


Switching times vs collector current
 $T_j=150\text{ }^\circ\text{C}$

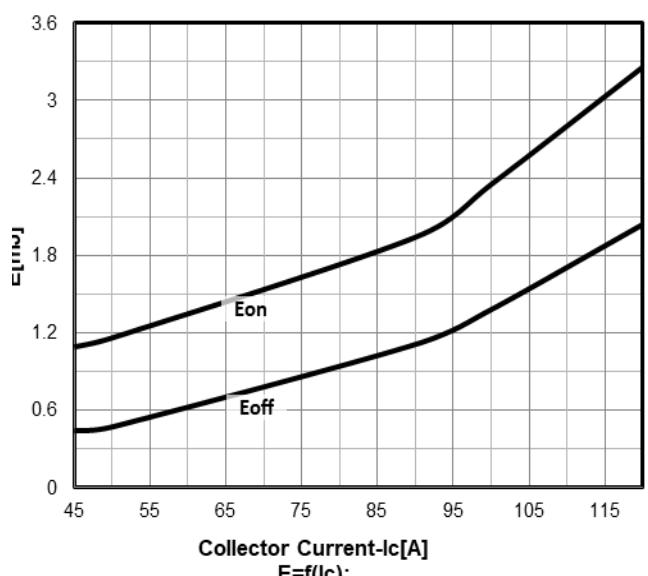
t, switching times



Switching energy losses vs collector current
 $T_j=25\text{ }^\circ\text{C}$



Switching energy losses vs collector current
 $T_j=150\text{ }^\circ\text{C}$

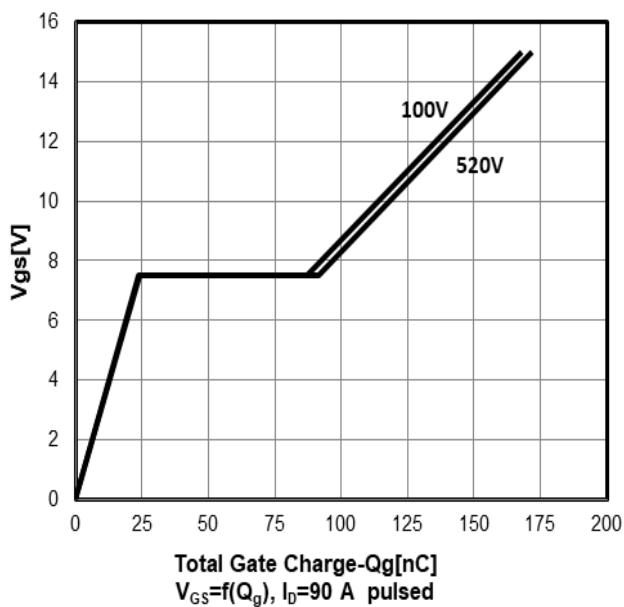




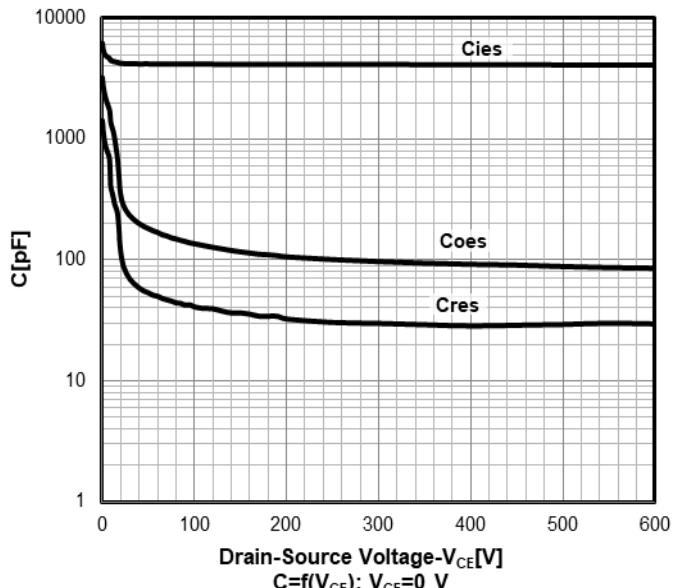
Typical Performance Characteristics

SiW90N65G2HP2D 650V Trench and Super Junction IGBT

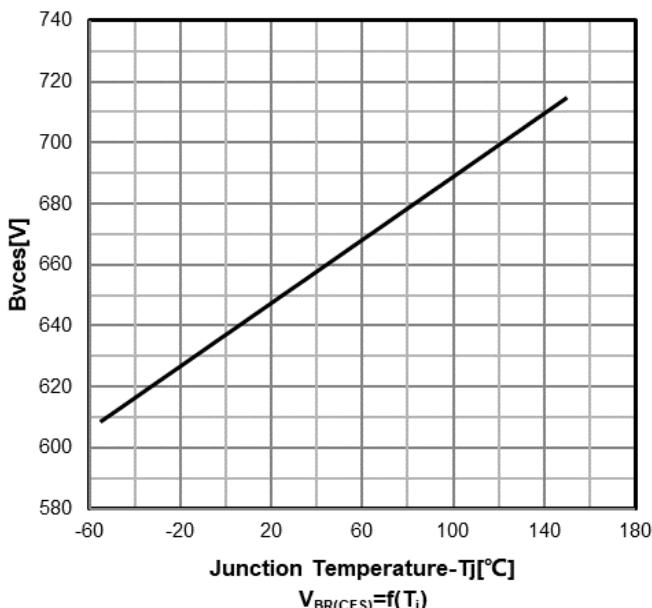
Gate charge characteristics



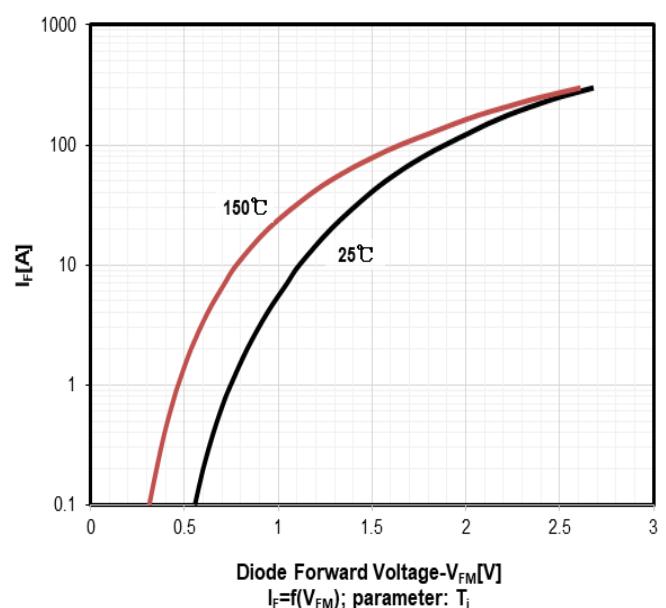
Capacitance characteristics



Collector-emitter breakdown voltage
vs. temperature



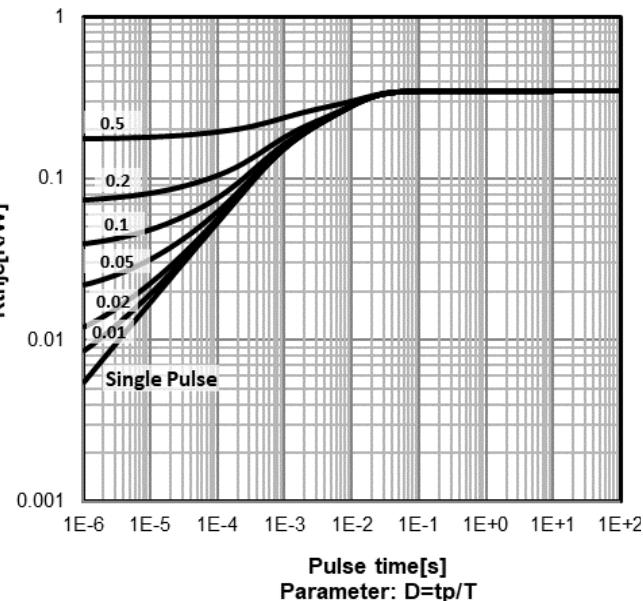
Forward characteristics of diode



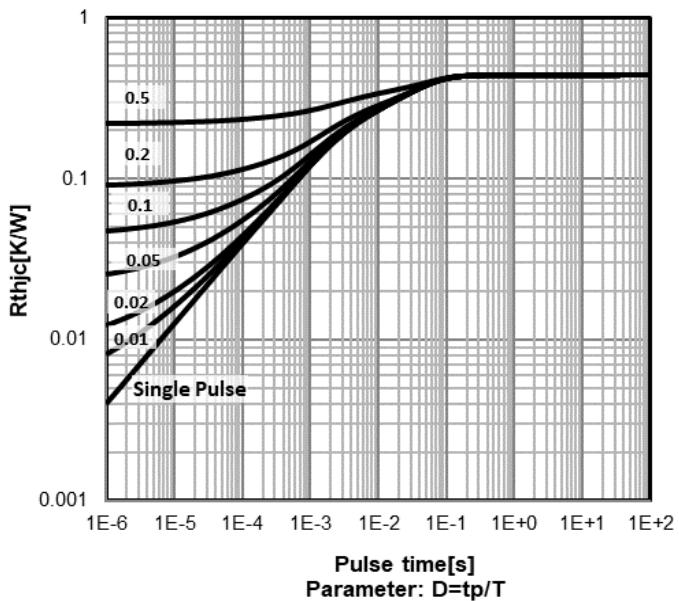


Typical Performance Characteristics

Max. transient thermal impedance
parameter: D=tp/T; IGBT



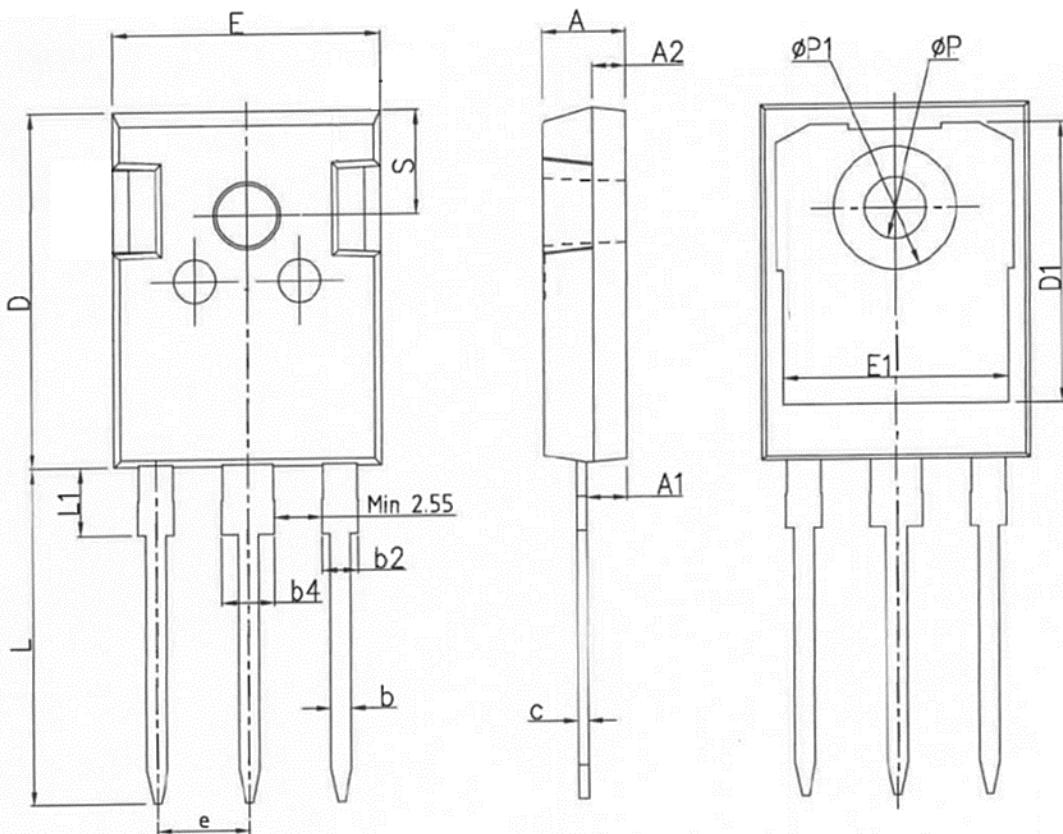
Max. transient thermal impedance
parameter: D=tp/T; Diode





Package Outline

TO-247



COMMON DIMENSIONS

SYMBOL	UNIT(mm)		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.20	2.40	2.60
A2	1.85	2.00	2.15
b	1.10	1.20	1.35
b2	1.91	2.04	2.21
b4	2.91	3.04	3.21
c	0.50	0.60	0.75
D	20.70	21.00	21.30
D1	16.20	16.55	16.90
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
e	5.44BSC		
L	19.60	19.95	20.30
L1	-	-	4.30
ΦP	3.40	3.60	3.80
$\Phi P1$	-	-	7.50
S	6.15BSC		



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